# **Power MOSFET**

60 V, 295 mA, Dual N–Channel with ESD Protection, SC–88

## Features

- Low R<sub>DS(on)</sub>
- Low Gate Threshold
- Low Input Capacitance
- ESD Protected Gate
- This is a Pb–Free Device

#### Applications

- Low Side Load Switch
- DC-DC Converters (Buck and Boost Circuits)

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise stated)

Parameter			Symbol	Value	Units	
Drain-to-Source Voltage	V <sub>DSS</sub>	60	V			
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V	
Continuous Drain	Steady	$T_A = 25^{\circ}C$	Ι <sub>D</sub>	295	mA	
Current (Note 1)	State	$T_A = 85^{\circ}C$		212		
	t ≤ 5 s	$T_A = 25^{\circ}C$	1	304		
		$T_A = 85^{\circ}C$	1	219		
Power Dissipation (Note 1)	Steady State	$T_A = 25^{\circ}C$	P <sub>D</sub>	250	mW	
	t ≤ 5 s			266		
Pulsed Drain Current	t <sub>p</sub> = 10 μs		I <sub>DM</sub>	900	mA	
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C	
Source Current (Body Did	ode)		I <sub>S</sub>	210	mA	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C	
Gate–Source ESD Rating (HBM, Method 3015)			ESD	1400	V	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

## THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Units
Junction-to-Ambient - Steady State	$R_{\theta JA}$	500	°C/W
Junction-to-Ambient – t $\leq$ 5 s	$R_{\theta JA}$	470	

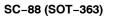
1. Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).

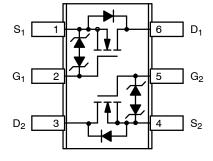


# **ON Semiconductor®**

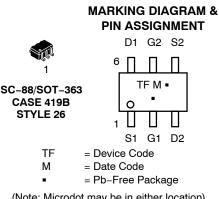
## http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> Max
60 V	1.6 Ω @ 10 V	295 mA
	2.5 Ω @ 4.5 V	295 IIIA





Top View



(Note: Microdot may be in either location)

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTJD5121NT1G	SC-88 (Pb-Free)	3000 / Tape & Reel
NTJD5121NT2G	SC-88 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

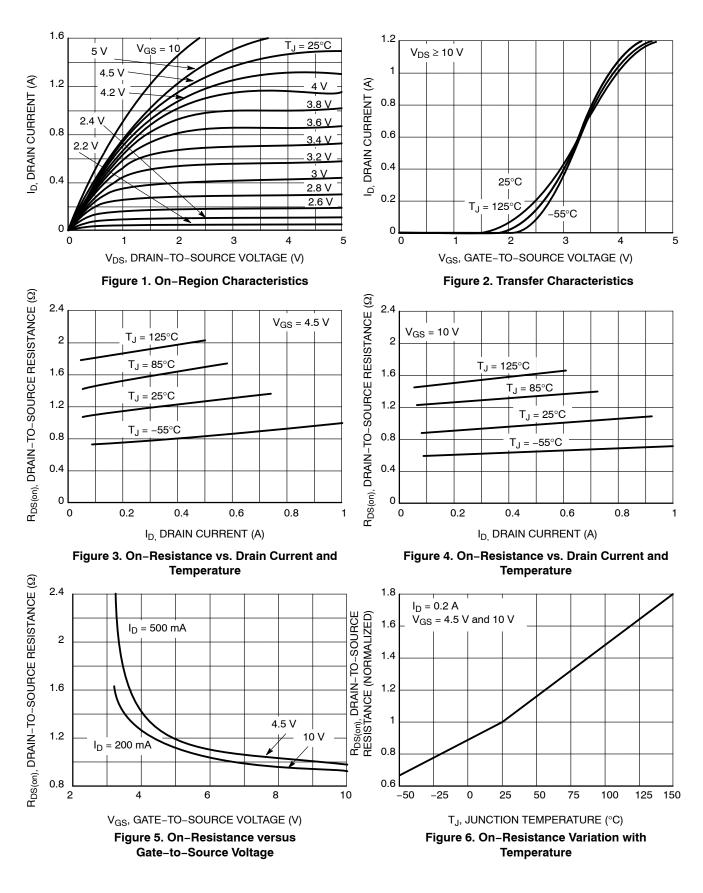
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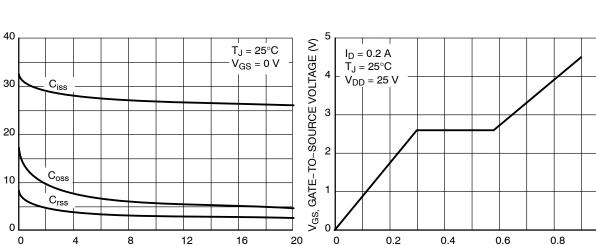
# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Мах	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA, r	ef to 25°C		92		mV/°C
Zero Gate Voltage Drain Current	$I_{DSS} \qquad \begin{array}{c} V_{GS} = 0 \ V, \\ V_{DS} = 60 \ V \end{array}$	$T_J = 25^{\circ}C$			1.0	μA	
		$V_{DS} = 60 V$	T <sub>J</sub> = 125°C			500	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{G}$	<sub>S</sub> = ±20 V			±10	μA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μA	1.0	1.7	2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 500 mA			1.0	1.6	Ω
	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> =		) = 200 mA		1.2	2.5	
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 200 mA			80		S
CHARGES AND CAPACITANCES					•		
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 20 V			26		pF
Output Capacitance	C <sub>OSS</sub>				4.4		
Reverse Transfer Capacitance	C <sub>RSS</sub>	•03			2.5		1
Total Gate Charge	Q <sub>G(TOT)</sub>				0.9		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 25 V,			0.2		
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = 200	mA		0.3		
Gate-to-Drain Charge	Q <sub>GD</sub>		Ē		0.28		
SWITCHING CHARACTERISTICS (No	ote 3)						
Turn-On Delay Time	t <sub>d(on)</sub>				22		ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = 45 V, $V_{DD}$ = 25 V, $I_{D}$ = 200 mA, $R_{G}$ = 25 $\Omega$			34		
Turn-Off Delay Time	t <sub>d(off)</sub>				34		
Fall Time	t <sub>f</sub>				32		
DRAIN-SOURCE DIODE CHARACTE	RISTICS				•	-	
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.8	1.2	V
		I <sub>S</sub> = 200 mA	T <sub>J</sub> = 85°C		0.7		

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

# TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)





# TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)



C, CAPACITANCE (pF)

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

Q<sub>g</sub>, TOTAL GATE CHARGE (nC)

1

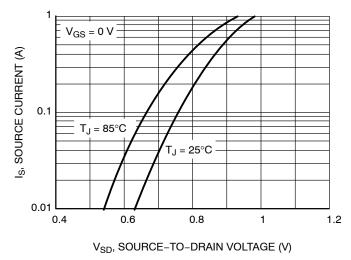
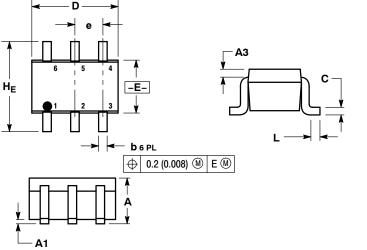


Figure 9. Diode Forward Voltage vs. Current

#### PACKAGE DIMENSIONS

SC-88/SC70-6/SOT-363 CASE 419B-02 **ISSUE W** 



NOTES: DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

CONTROLLING DIMENSION: INCH. 2

419B-01 OBSOLETE, NEW STANDARD 419B-02.

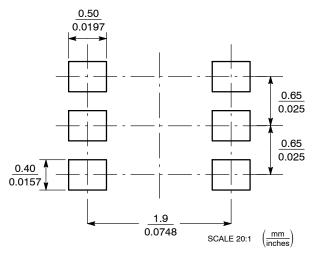
	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.80	0.95	1.10	0.031	0.037	0.043	
A1	0.00	0.05	0.10	0.000	0.002	0.004	
A3	0.20 REF			0.008 REF			
b	0.10	0.21	0.30	0.004	0.008	0.012	
С	0.10	0.14	0.25	0.004	0.005	0.010	
D	1.80	2.00	2.20	0.070	0.078	0.086	
Е	1.15	1.25	1.35	0.045	0.049	0.053	
е	0.65 BSC			0.026 BSC			
L	0.10	0.20	0.30	0.004	0.008	0.012	
HE	2.00	2.10	2.20	0.078	0.082	0.086	



4. SOURCE 2

5. GATE 2 6. DRAIN 1 DRAIN 1

#### SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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